

Notice of References Cited	Application/Control No. 10/606,270	Applicant(s)/Patent Under Reexamination SHIBATA, MICHIIRO	
	Examiner Tianjie Chen	Art Unit 2656	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08263880 A	10-1996	Japan	HANZAWA et al.	-----
	O	JP 11053778 A	02-1999	Japan	MATSUNAGA et al.	-----
	P	JP 11144325 A	05-1999	Japan	DAIKO, TAKASHI	-----
	Q	JP 10199040 A	07-1998	Japan	IIMURA, JUNICHI	-----
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.